

Report No. : EED32O80707901

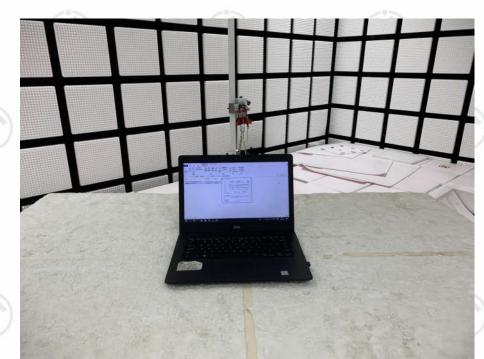


7 PHOTOGRAPHS OF TEST SETUP

Test model No.:K1616-833



Radiated spurious emission Test Setup-1(Below 1GHz)



Radiated spurious emission Test Setup-2(1-18 GHz)



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